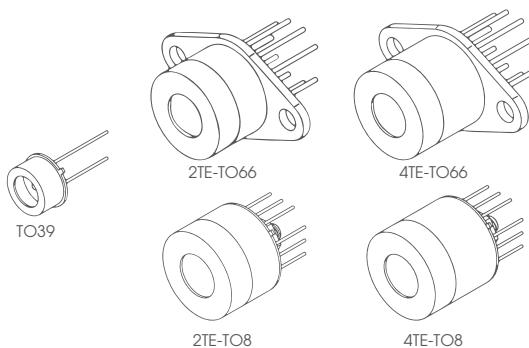


PVMI-10.6 SERIES

HgCdTe room temperature and thermoelectrically cooled photovoltaic multi-junction optically immersed infrared detectors



FEATURES

- Spectral range: 2.0 to 13.0 μm
- Back-side illuminated
- Unique immersion lens technology applied
- No minimum order quantity required

RELATED PRODUCTS

- **LabM-I-10.6** detection module (p. 107)
- **UM-I-10.6** detection module (p. 113)
- **microM-10.6** detection module (p. 110)
- **PVIA-10.6-1x1-TO39-NW-36**
RoHS-compliant detector (p. 22)
- **PVIA-4TE-10.6-1x1-TO8-wZnSeAR-36**
RoHS-compliant detector (p. 22)

APPLICATIONS

- Gas detection, monitoring and analysis: SO_2 , NH_3 , SF_6
- CBRN threats detection
- CO_2 laser measurements: power monitoring and control, beam profiling and positioning, calibration
- Free-space optical communication
- FTIR spectroscopy
- Medical bacteria identification
- Dentistry
- Glucose sensing

SERIES DESCRIPTION

Detector symbol	Cooling (p. 191)	Temperature sensor (p. 192)	Optical area, A_o , mm \times mm	Optical immersion (p. 188)	Package	Acceptance angle, Φ , deg.	Window (p. 193)
PVMI-10.6-1x1-TO39-NW-36	no	n/a			TO39 (3 pins)		no
PVMI-2TE-10.6-1x1-TO8-wZnSeAR-36					TO8		
PVMI-2TE-10.6-1x1-TO66-wZnSeAR-36		2TE $T_{\text{chip}} \approx 230\text{K}$		1x1 hyperhemisphere	TO66	~36	wZnSeAR (3 deg. zinc selenide, anti-reflection coating)
PVMI-4TE-10.6-1x1-TO8-wZnSeAR-36					TO8		
PVMI-4TE-10.6-1x1-TO66-wZnSeAR-36		4TE $T_{\text{chip}} \approx 197\text{K}$			TO66		



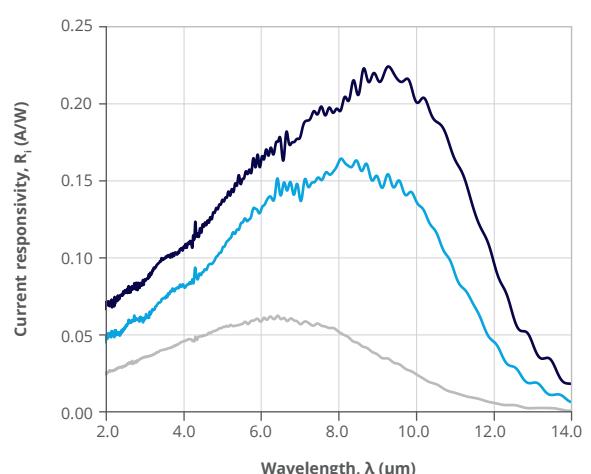
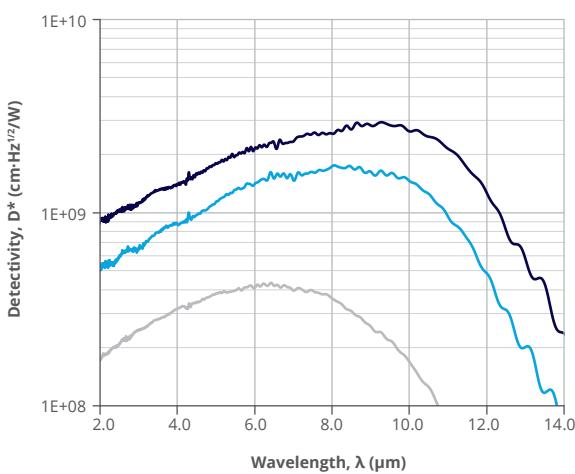
SPECIFICATION ($T_{\text{amb}} = 293 \text{ K}$, $V_b = 0 \text{ V}$)

Detector symbol	Cut-on wavelength (10%)	Peak wavelength	Specific wavelength	Cut-off wavelength (10%)	Detectivity		Current responsivity		Time constant	Dynamic resistance			
	$\lambda_{\text{cut-on}}$	λ_{peak}	λ_{spec}	$\lambda_{\text{cut-off}}$	$D^*(\lambda_{\text{peak}}, 20\text{kHz})$	$D^*(\lambda_{\text{spec}}, 20\text{kHz})$	$R(\lambda_{\text{peak}})$	$R(\lambda_{\text{spec}})$	τ	R_d			
	μm	μm	μm	μm	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	A/W	A/W	ns	Ω			
	Typ.	Typ.	Typ.	Typ.	Typ.	Typ.	Typ.	Min.	Typ.	Min.			
PVMI-10.6-1x1-T039-NW-36		8.5 ± 1.0			12.0	2.0×10^8	1.0×10^8	0.02	0.01	0.015	1.5	20	50
PVMI-2TE-10.6-1x1-T08-wZnSeAR-36													
		8.0 ± 1.0			13.0	2.0×10^9	1.0×10^9	0.2	0.1	0.12		90	120
PVMI-2TE-10.6-1x1-T066-wZnSeAR-36	2.0		10.6										3
PVMI-4TE-10.6-1x1-T08-wZnSeAR-36													
		9.0 ± 1.0			12.0	3.0×10^9	2.5×10^9	0.36	0.18	0.2		120	250
PVMI-4TE-10.6-1x1-T066-wZnSeAR-36													

SPECTRAL RESPONSE (Typ., $T_{\text{amb}} = 293 \text{ K}$)

— PVMI-10.6-1x1-T039-NW-36
 — PVMI-2TE-10.6-1x1-T08/T066-wZnSeAR-36
 — PVMI-4TE-10.6-1x1-T08/T066-wZnSeAR-36

— PVMI-10.6-1x1-T039-NW-36
 — PVMI-2TE-10.6-1x1-T08/T066-wZnSeAR-36
 — PVMI-4TE-10.6-1x1-T08/T066-wZnSeAR-36



MECHANICAL LAYOUT AND PINOUT

- TO39 (3 pins) package (without window)
 - Technical drawing (p. 198)
- 2TE-TO8 package
 - Technical drawing (p. 204)
- 2TE-TO66 package
 - Technical drawing (p. 206)
- 4TE-TO8 package
 - Technical drawing (p. 210)
- 4TE-TO66 package
 - Technical drawing (p. 212)

RECOMMENDED AMPLIFIERS

Detector symbol	Amplifier type
PVMI-10.6-1×1-TO39-NW-36	SIP-TO39 series (p. 138)
PVMI-2TE-10.6-1×1-TO8-wZnSeAR-36	AIP series (p. 126) PIP series (p. 129) MIP series (p. 132) SIP-TO8 series (p. 135)
PVMI-4TE-10.6-1×1-TO8-wZnSeAR-36	FIP series ^{*)} (p. 141)

^{*)} Only for biased detectors

ABSOLUTE MAXIMUM RATINGS

Parameter	Test conditions/remarks	Value	Unit
Ambient operating temperature, T_{amb}	Operation at $T_{\text{amb}} > 30^{\circ}\text{C}$ may increase the active element temperature and reduce the performance of the detector below specified parameters	-20 to 30	$^{\circ}\text{C}$
Storage temperature, T_{stg}		-20 to 50	$^{\circ}\text{C}$
Soldering temperature	Within 5 s or less	≤ 300	$^{\circ}\text{C}$
Storage humidity	No dew condensation	10 to 90	%
Maximum incident optical power density	Continuous wave (CW) or single pulses $> 1 \mu\text{s}$ duration	2.5	W/cm^2
	Single pulses $< 1 \mu\text{s}$ duration	10	kW/cm^2
Maximum bias voltage, $V_{\text{b max}}$	No bias voltage needed	-	-
Maximum TEC voltage, $V_{\text{TEC max}}$	2TE	1.3	V
	4TE	8.3	
Maximum TEC current, $I_{\text{TEC max}}$	2TE	1.2	A
	4TE	0.4	

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. Constant or repeated exposure to absolute maximum rating conditions may affect the quality and reliability of the device.